

Supplementary Information

Halide Insertion Regulation for Efficient and Stable Wide-Bandgap Perovskite Photovoltaics

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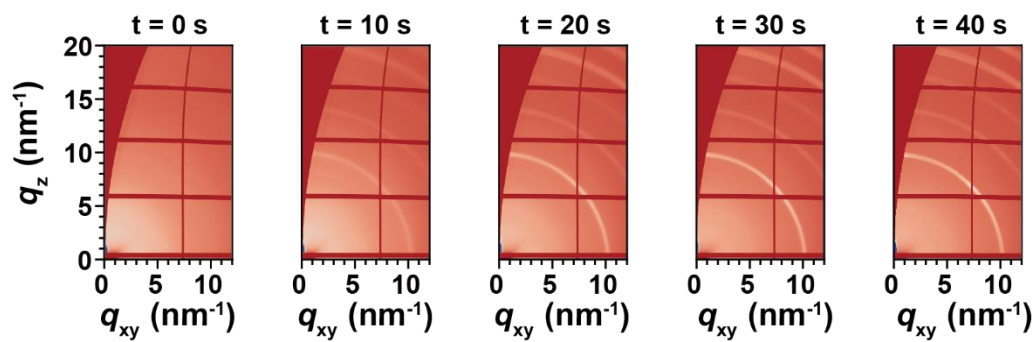
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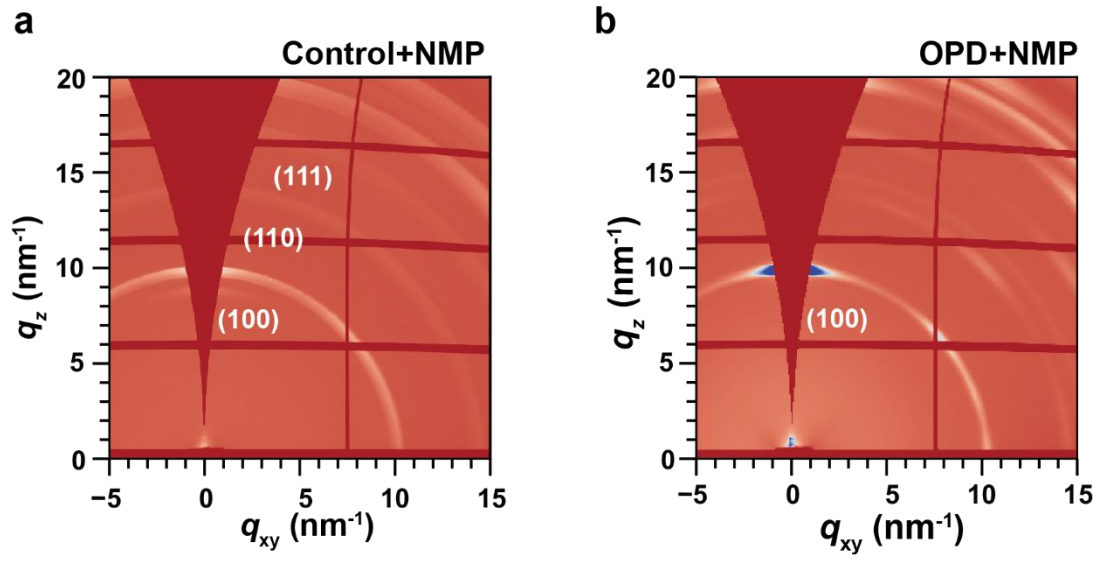
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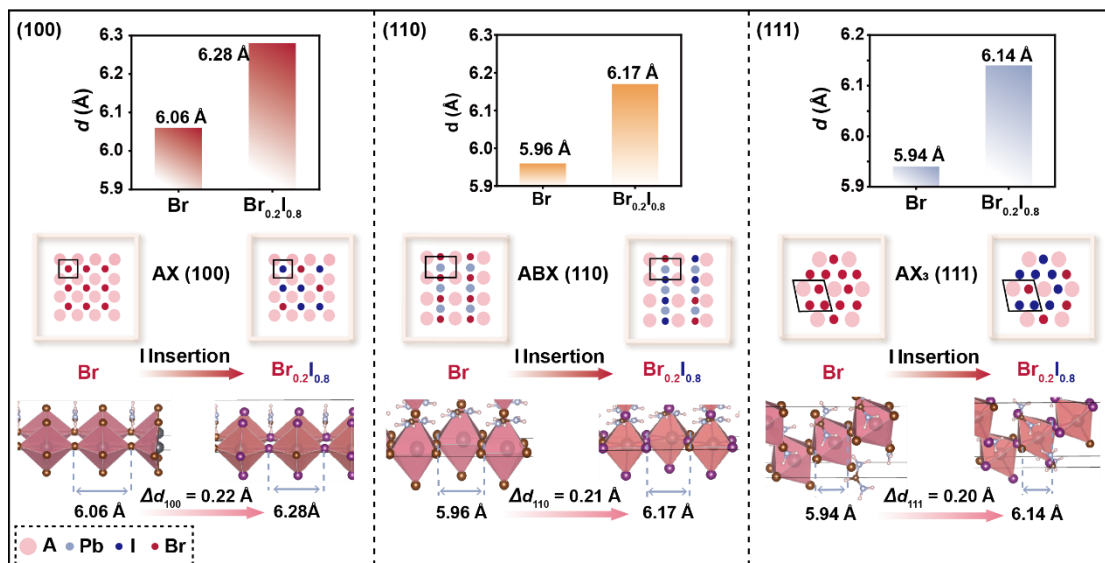
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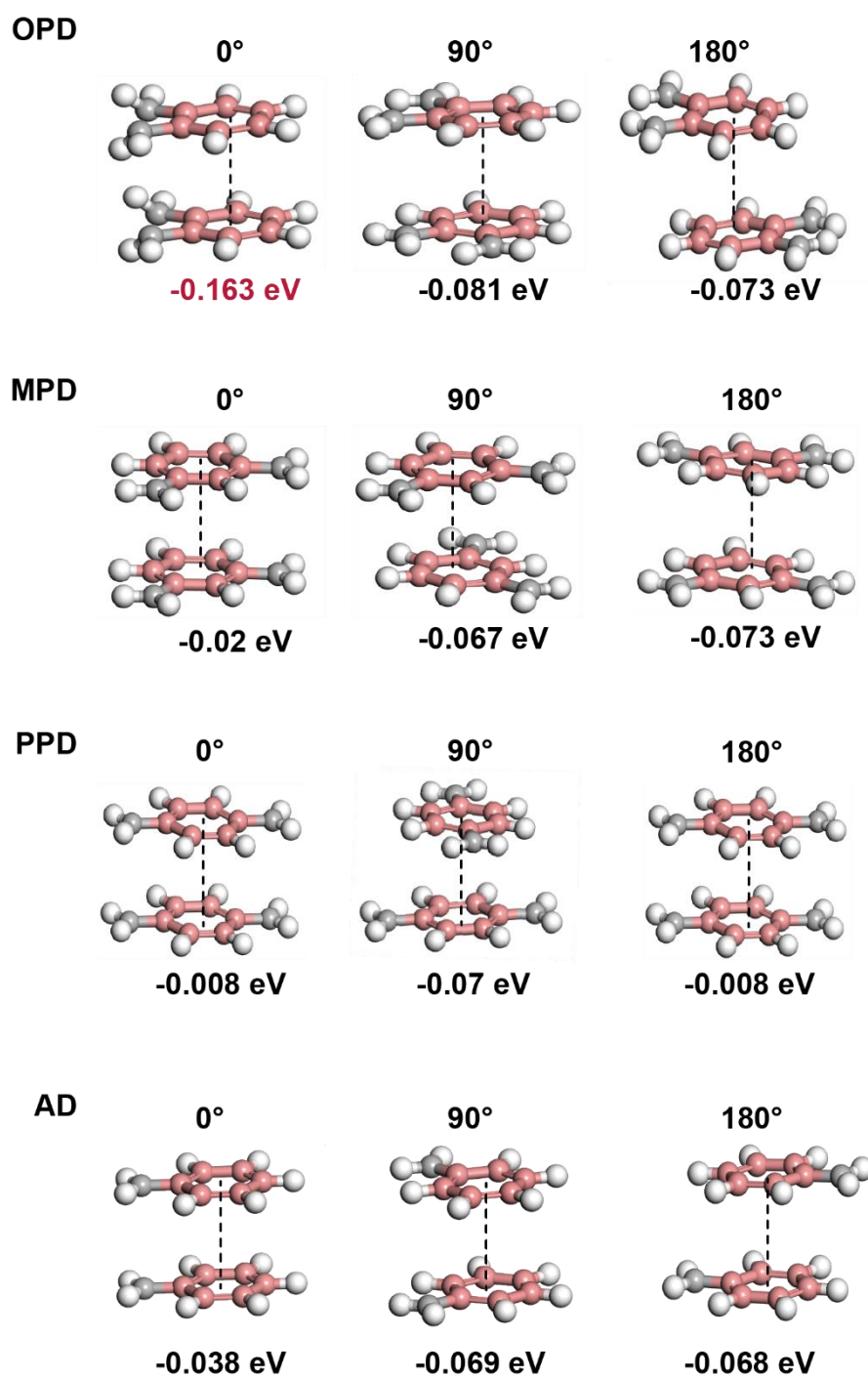
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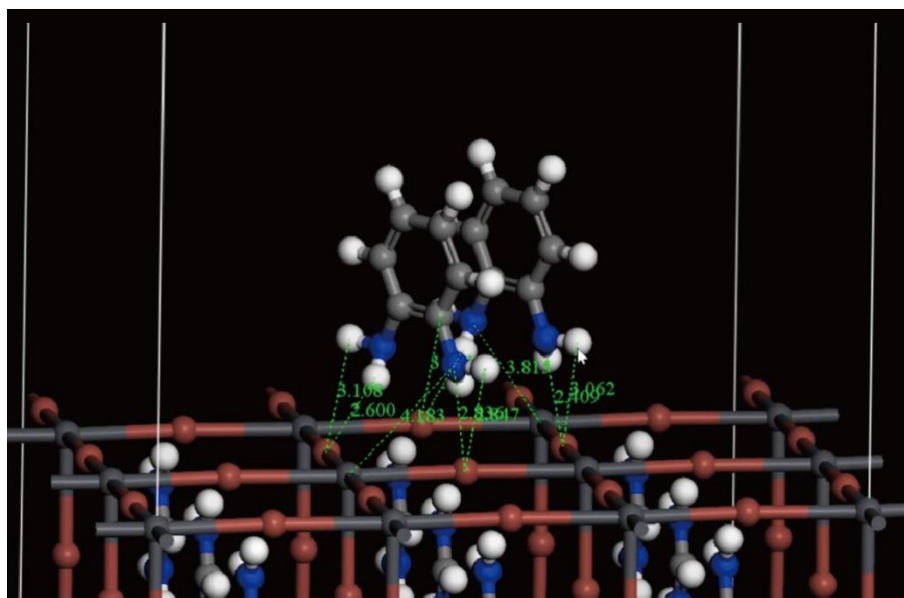
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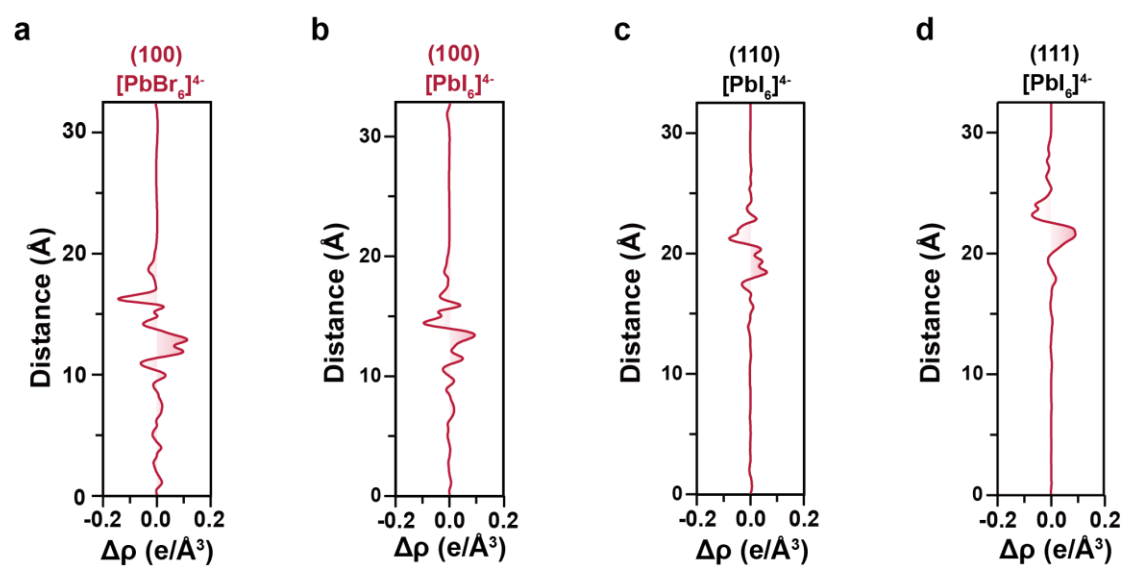
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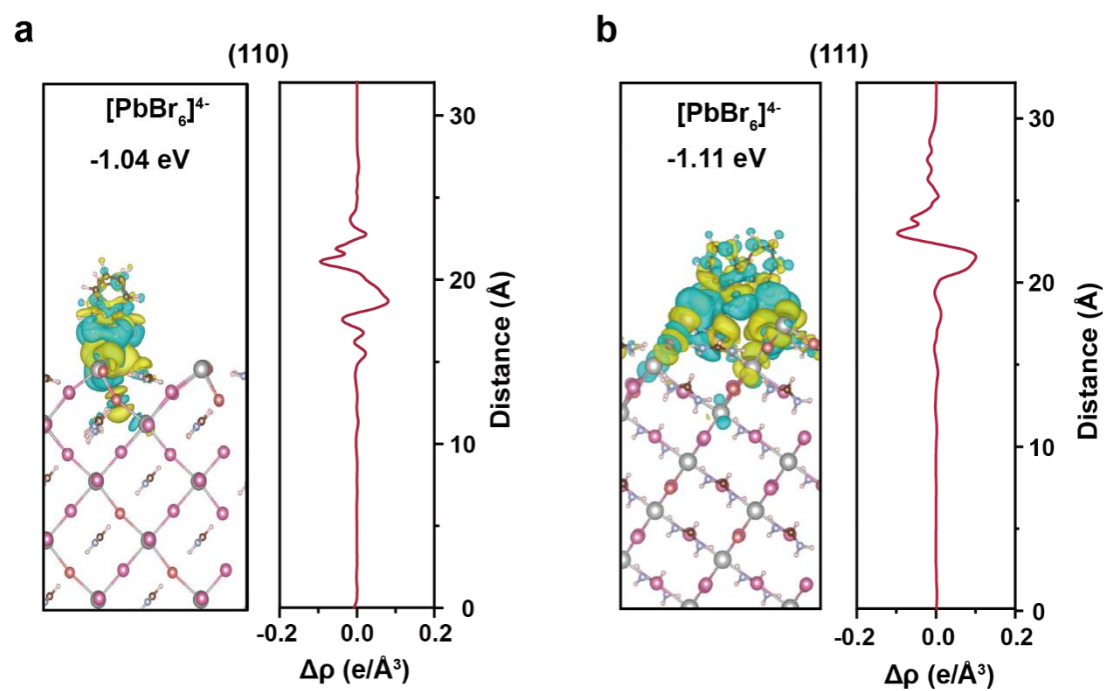
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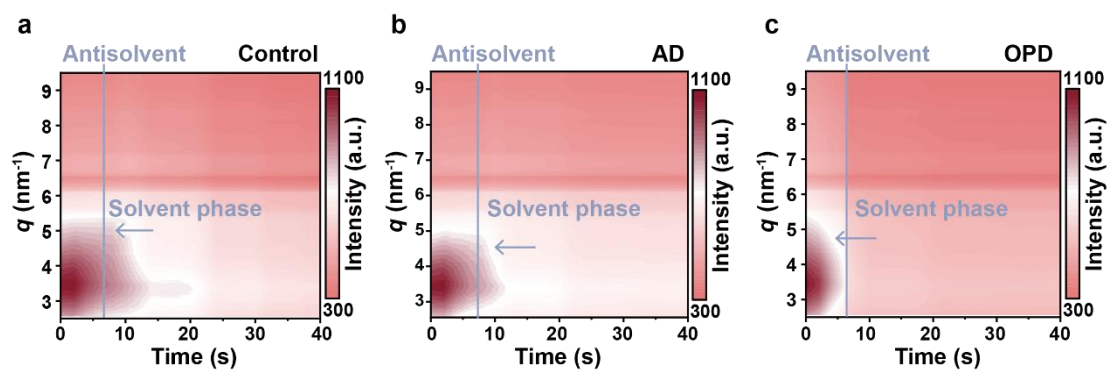
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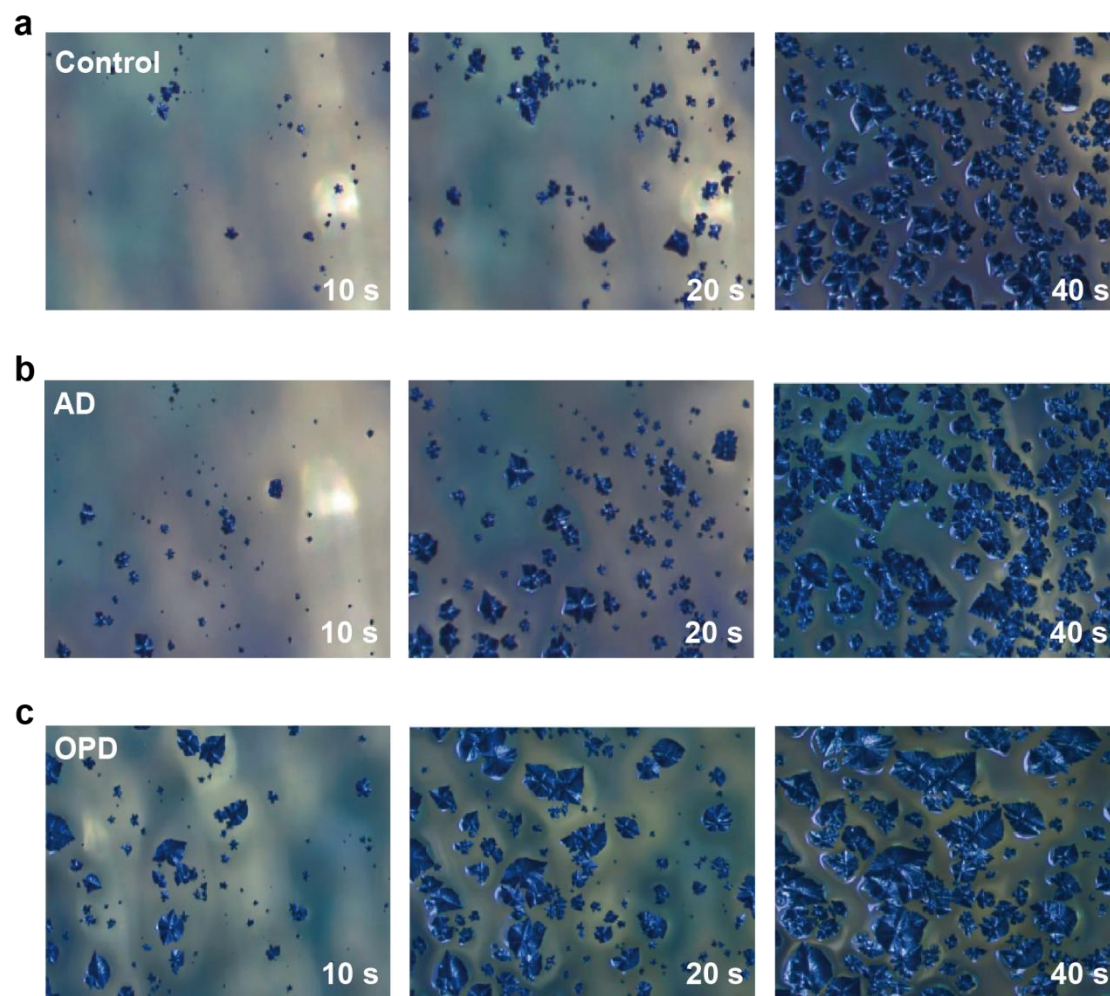
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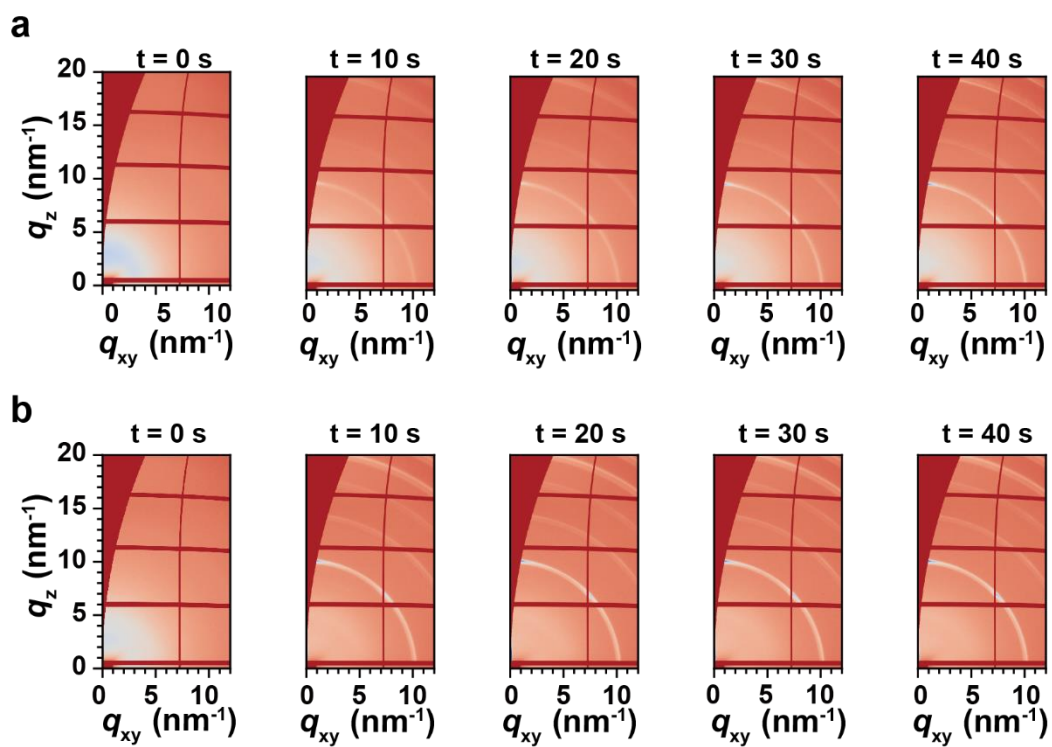
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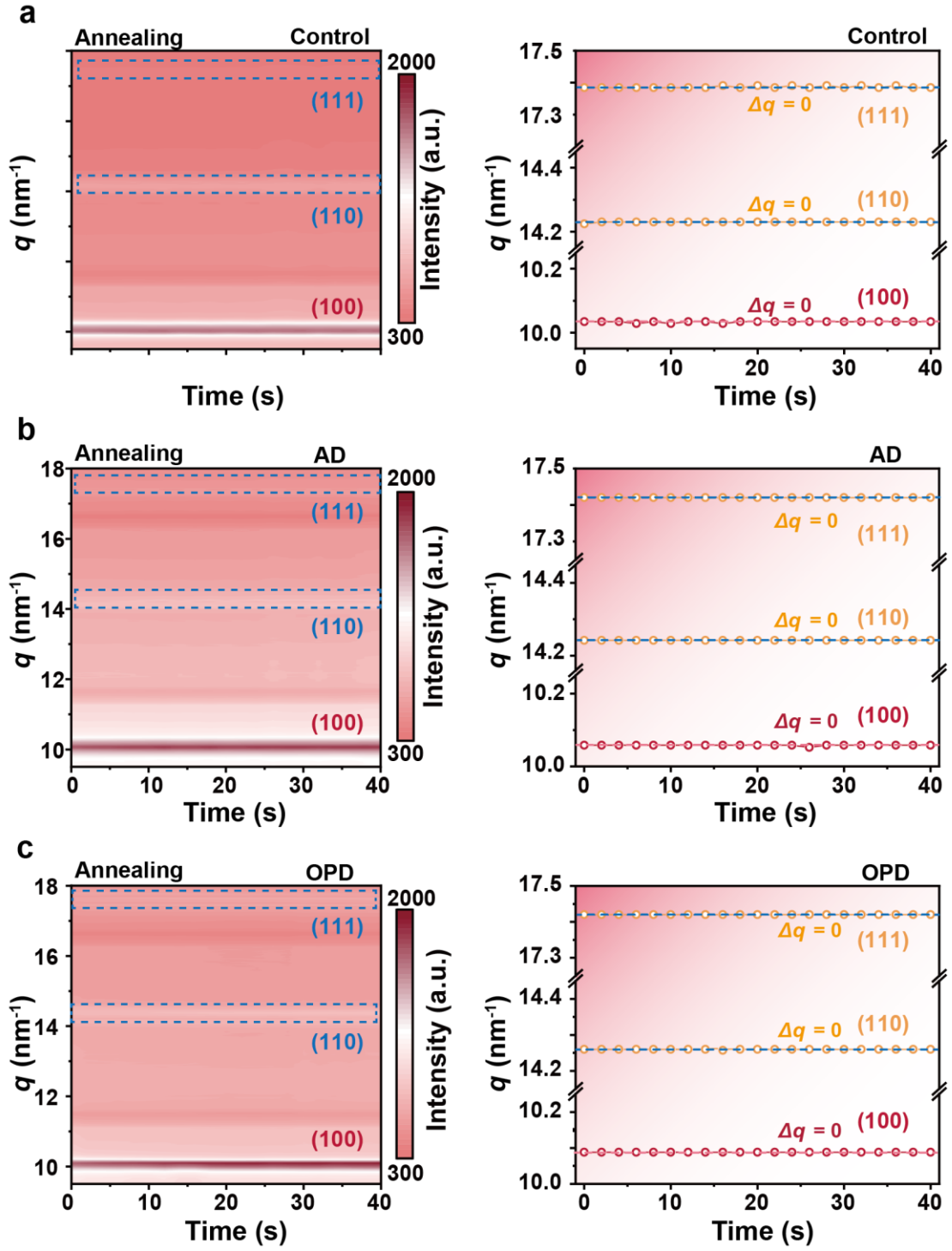
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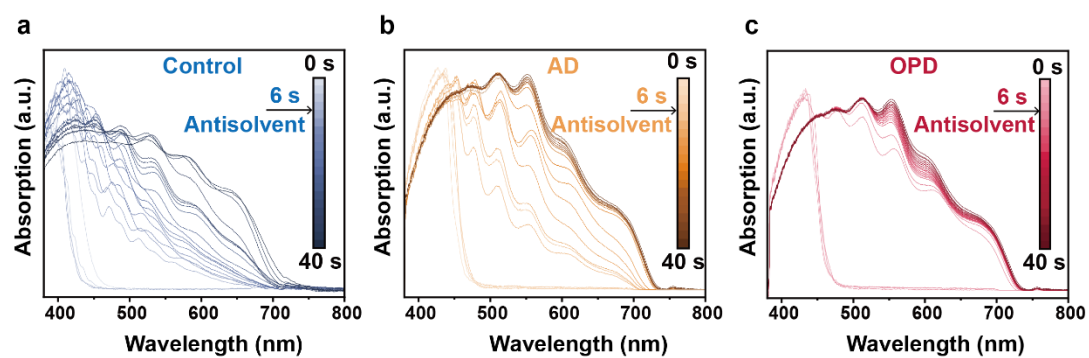
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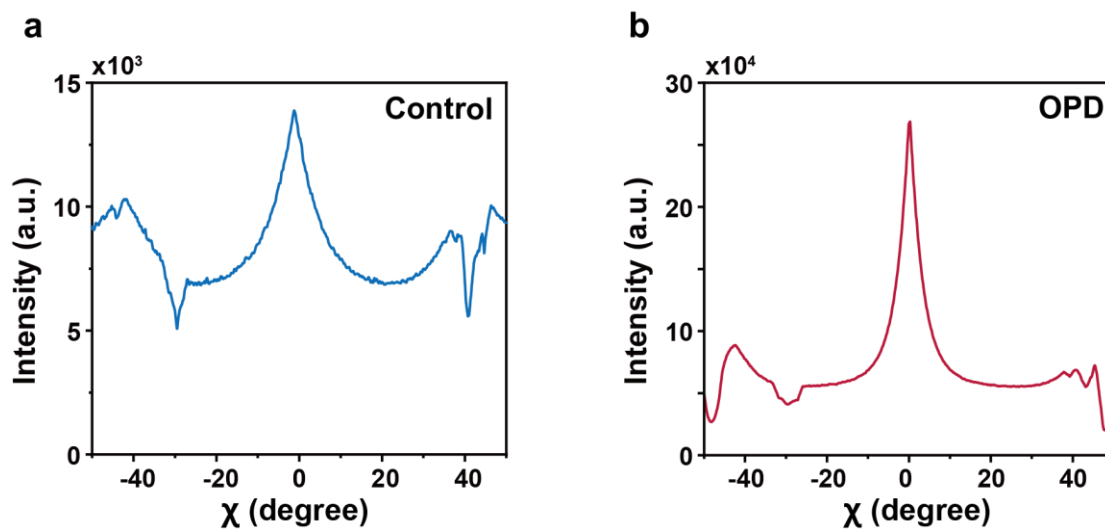
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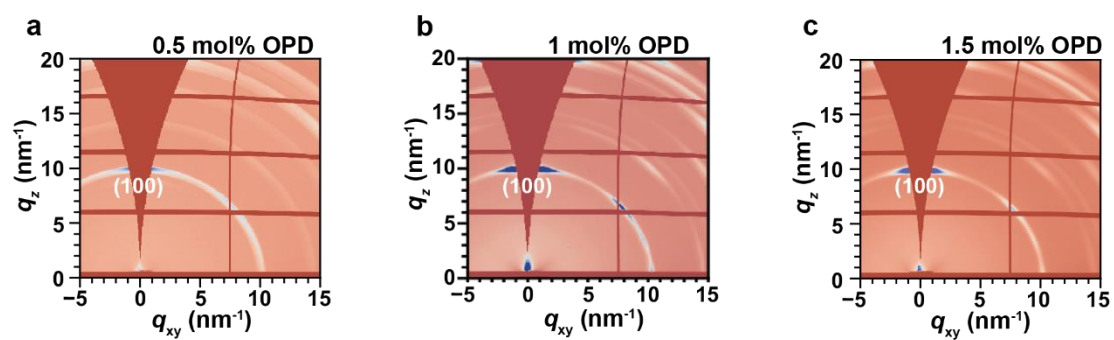
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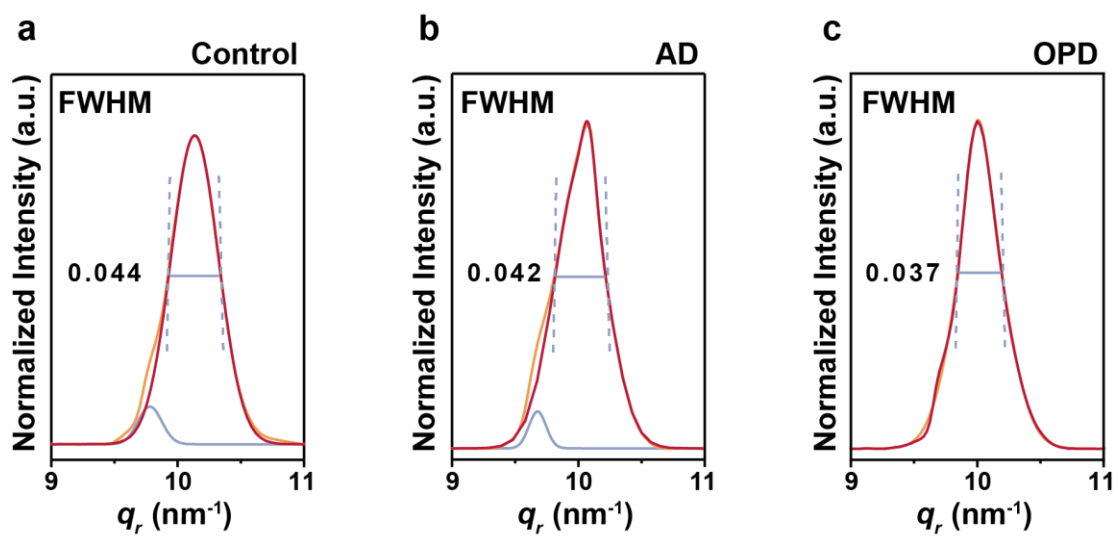
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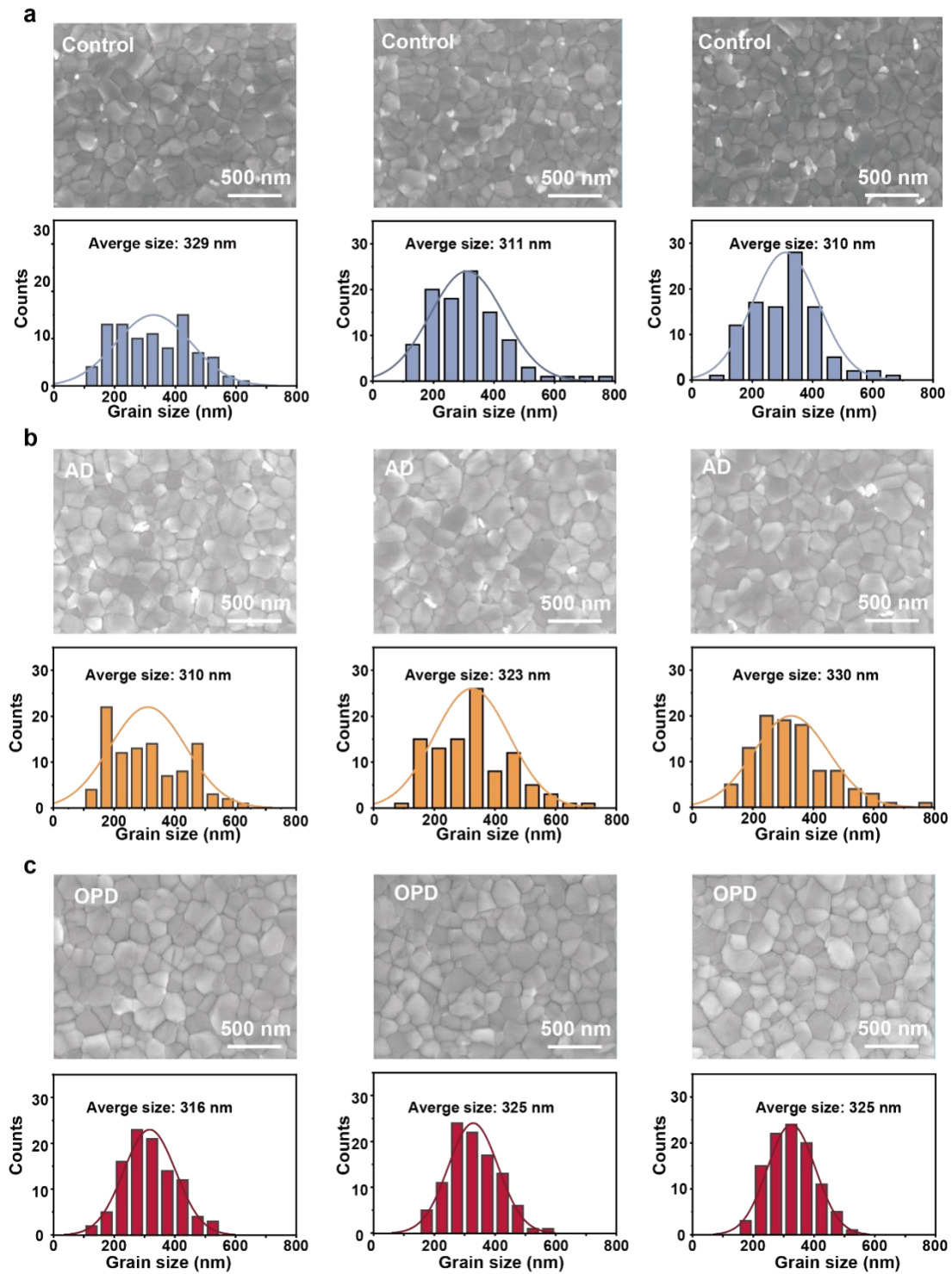
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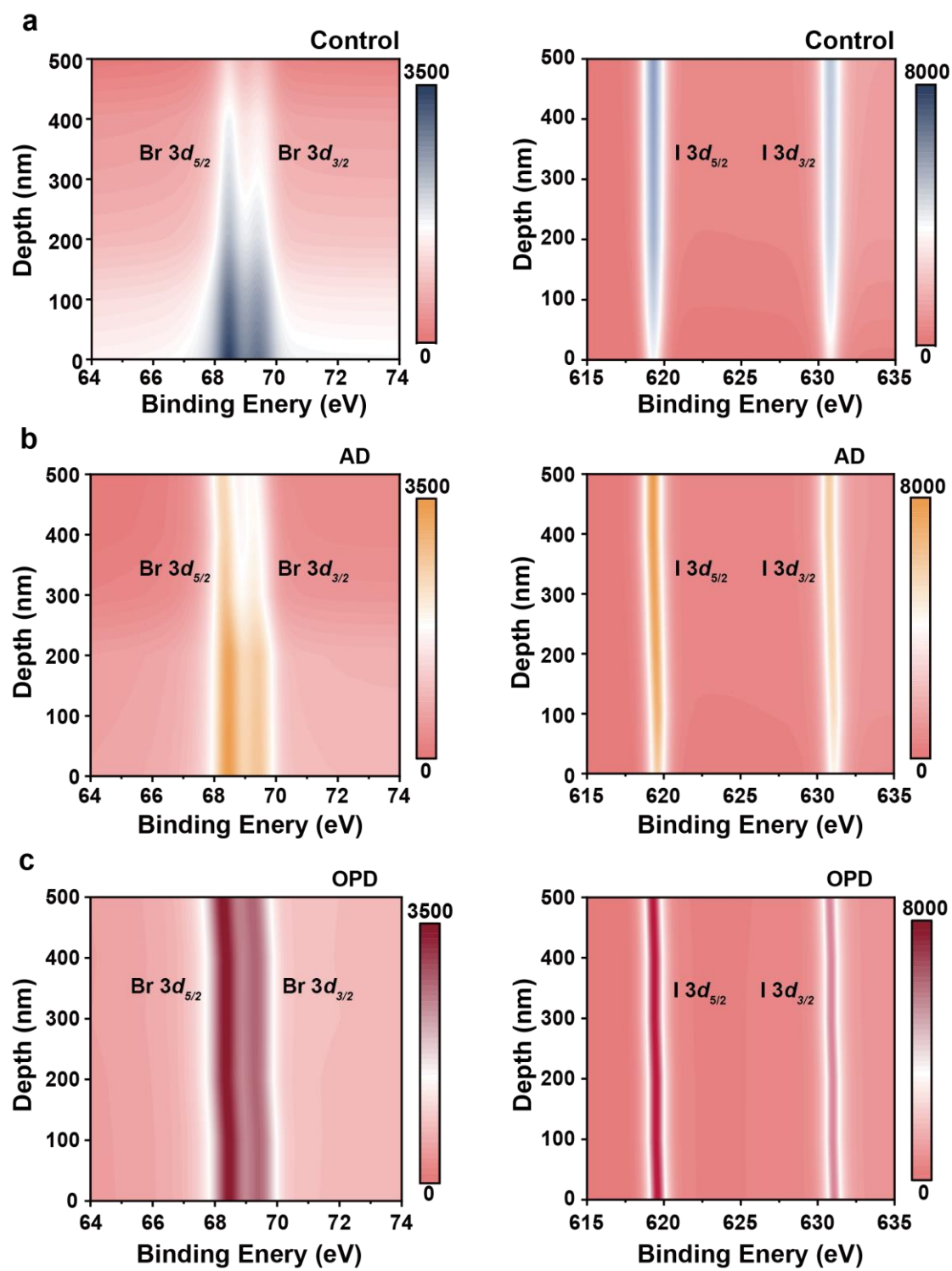
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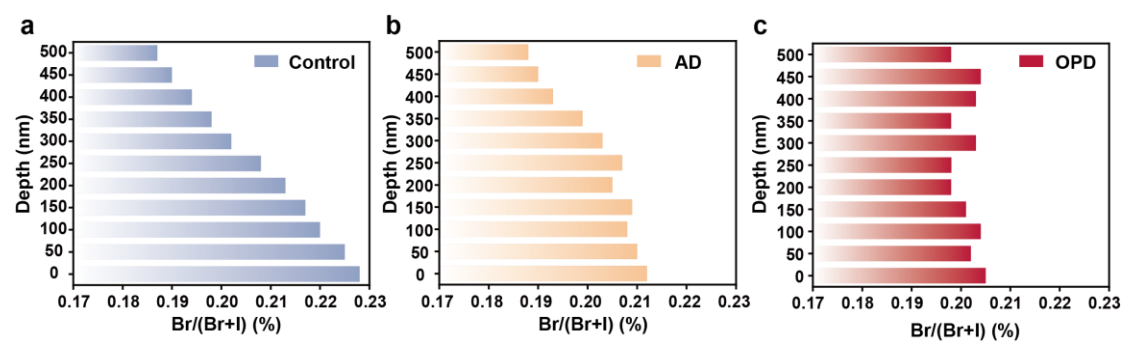
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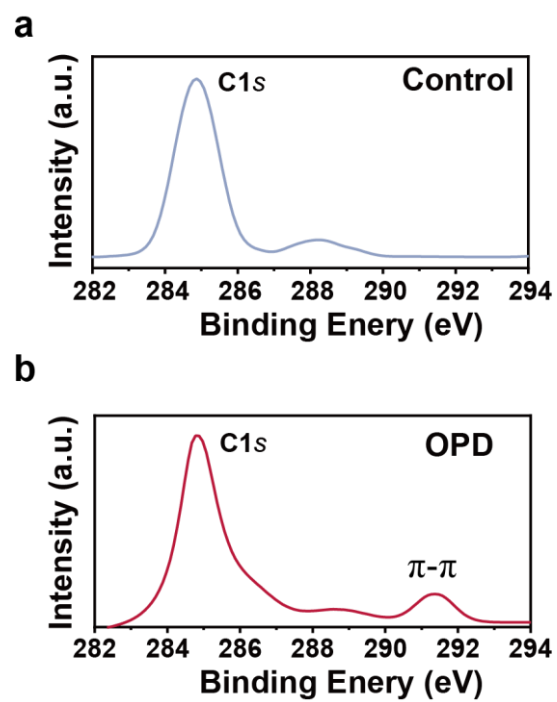
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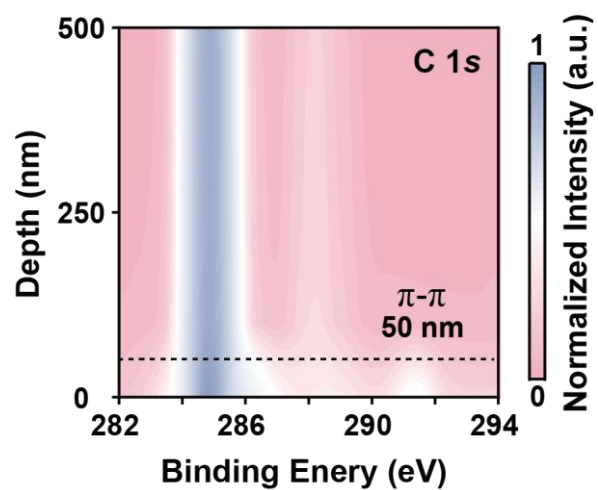
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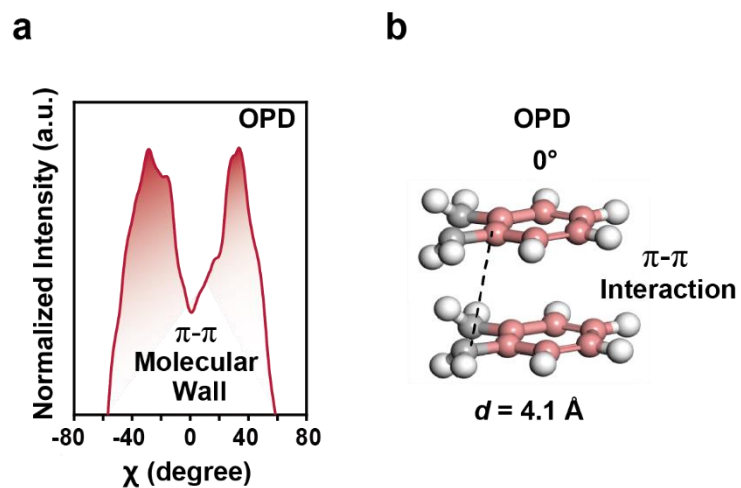
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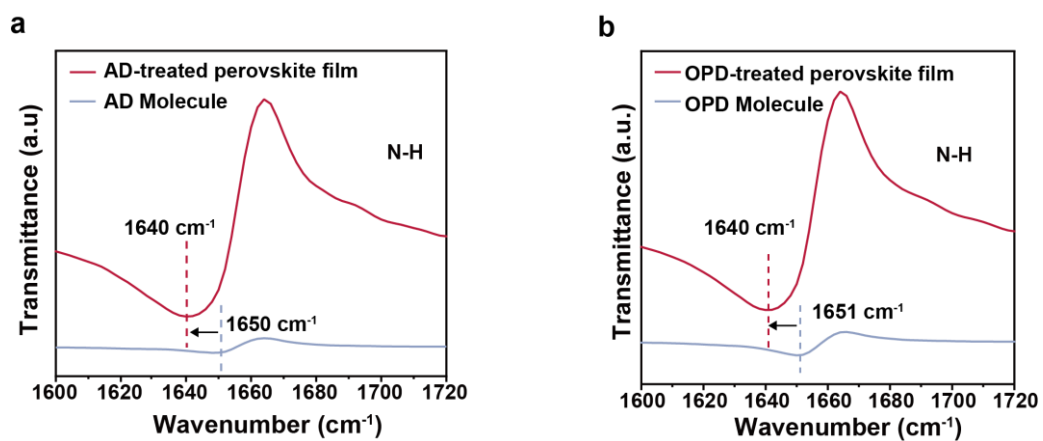
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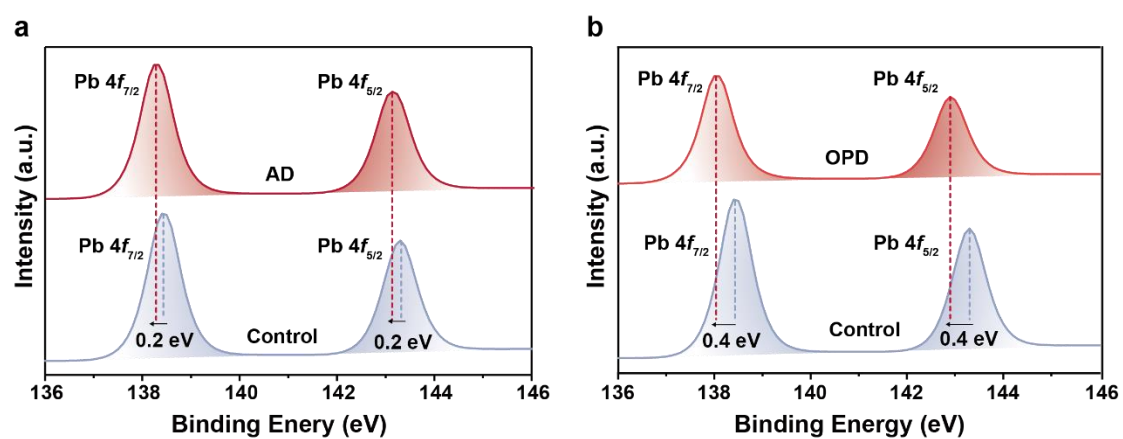
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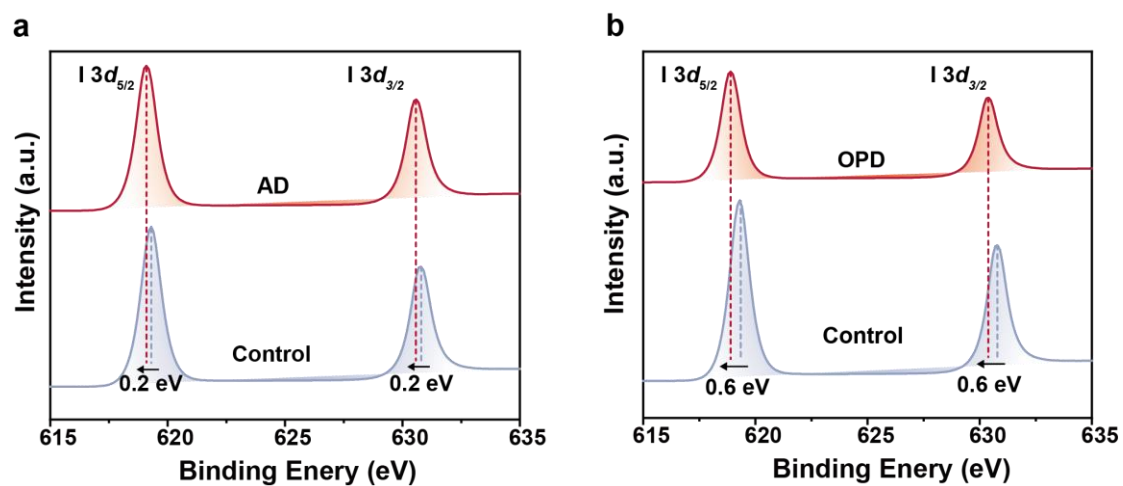
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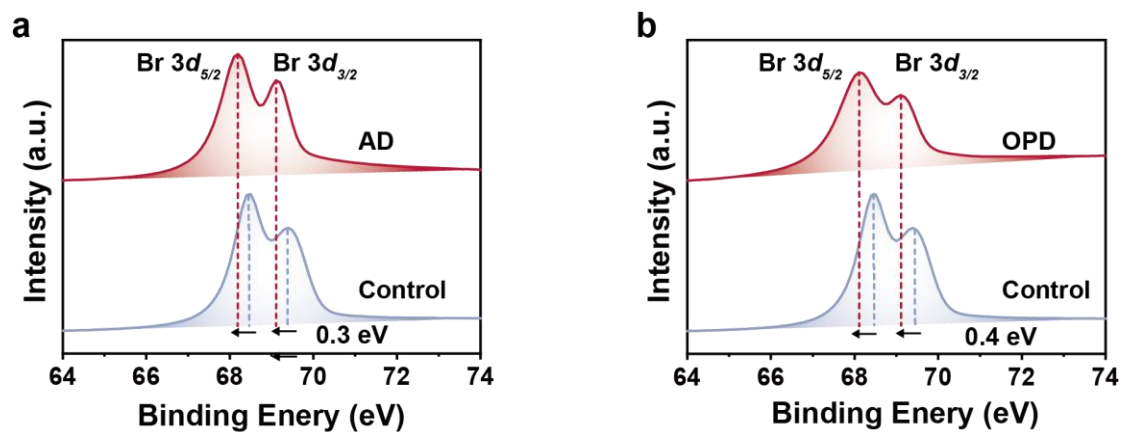
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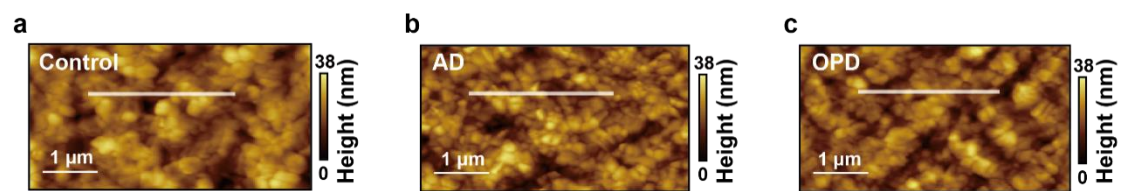
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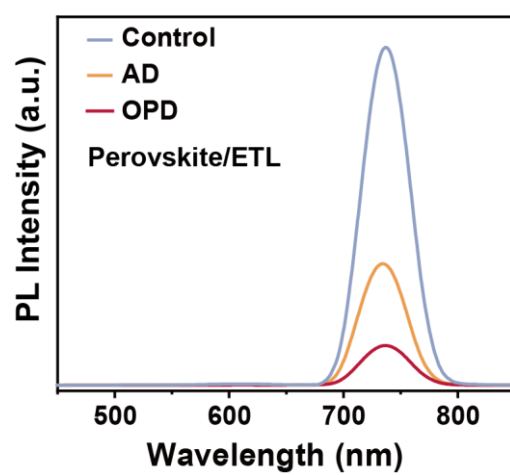
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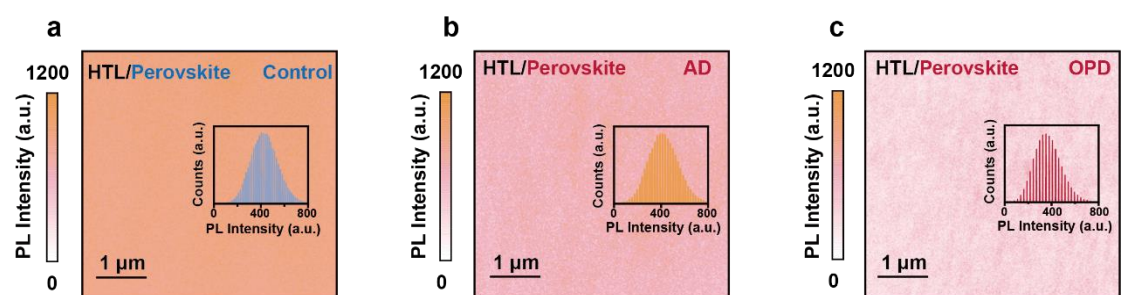
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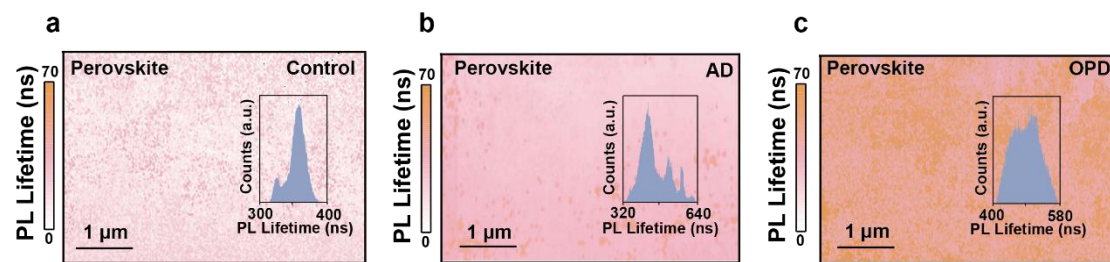
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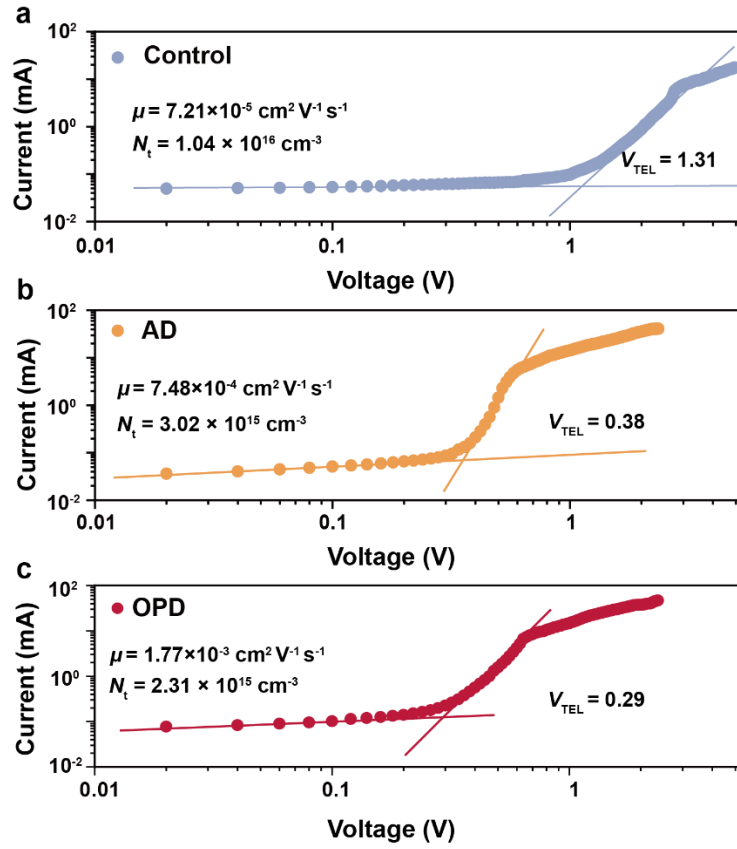
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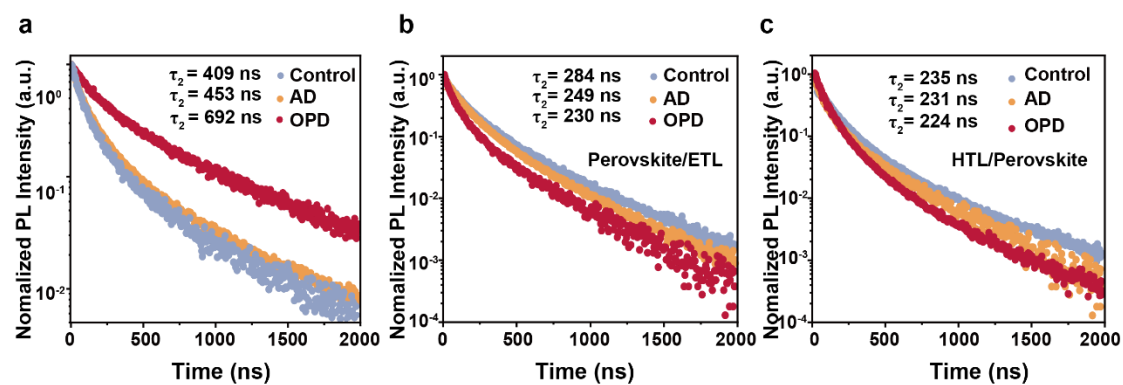
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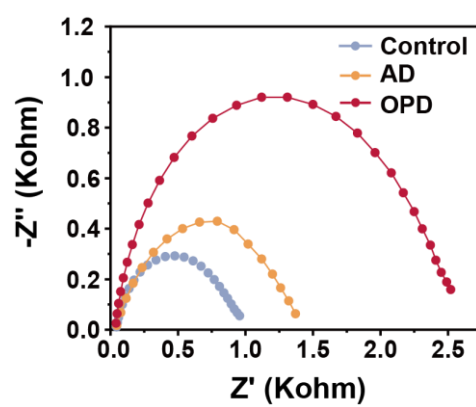
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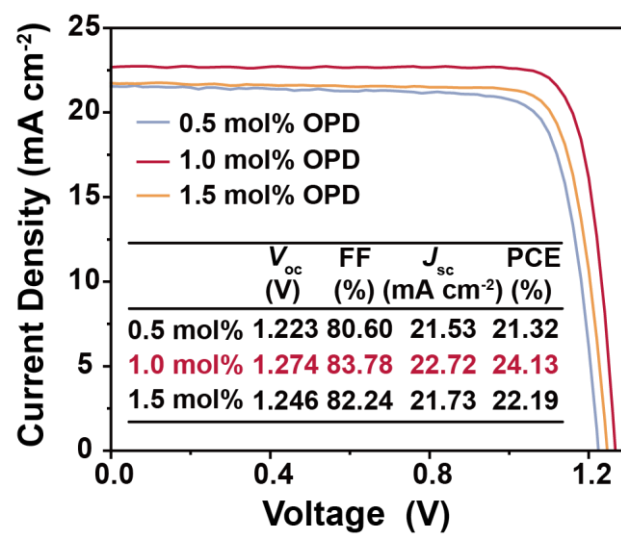
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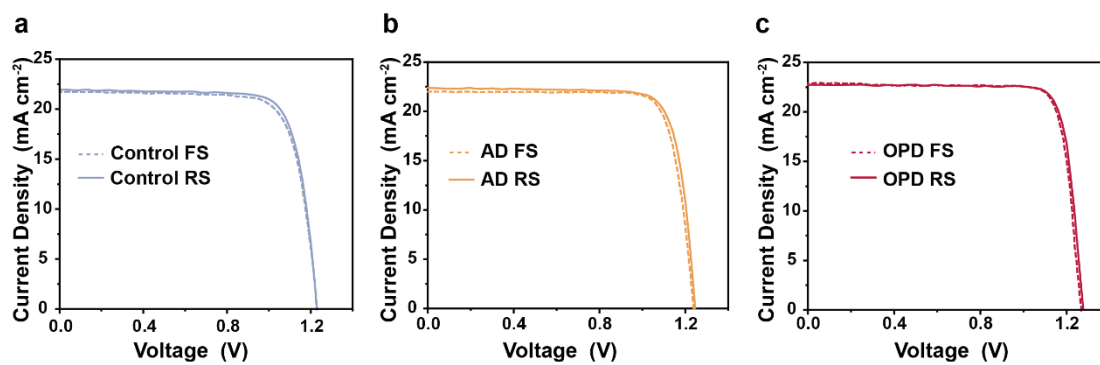
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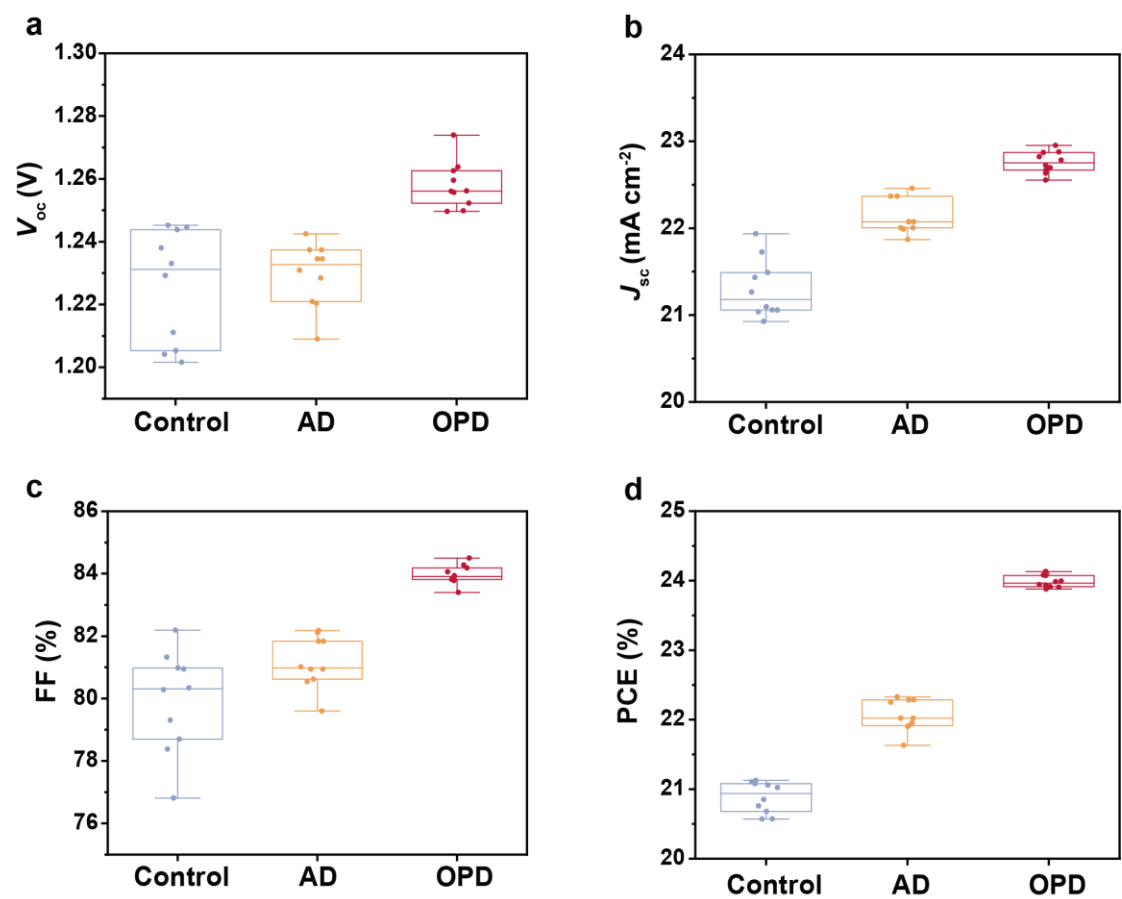
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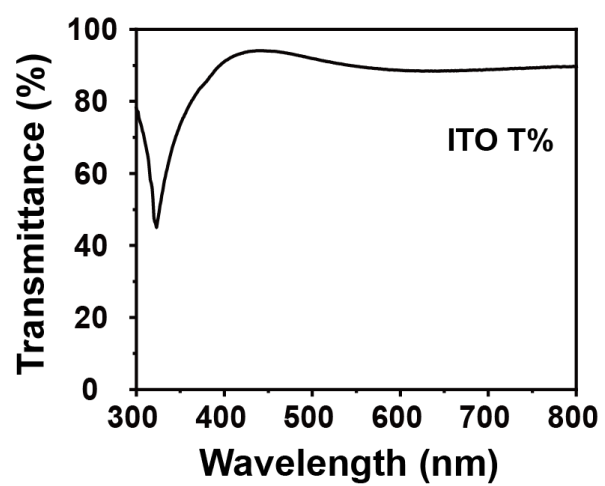
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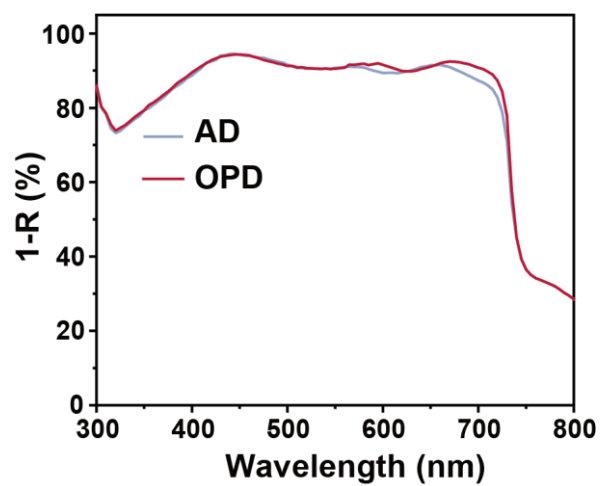
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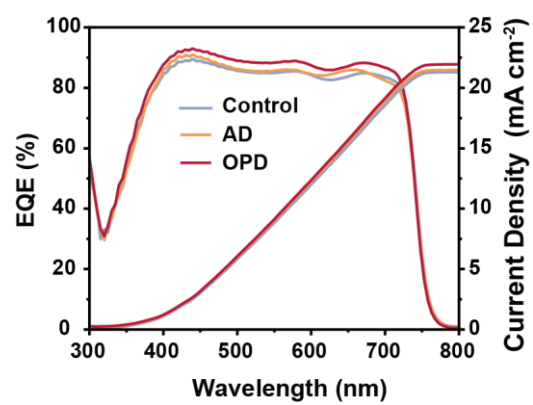
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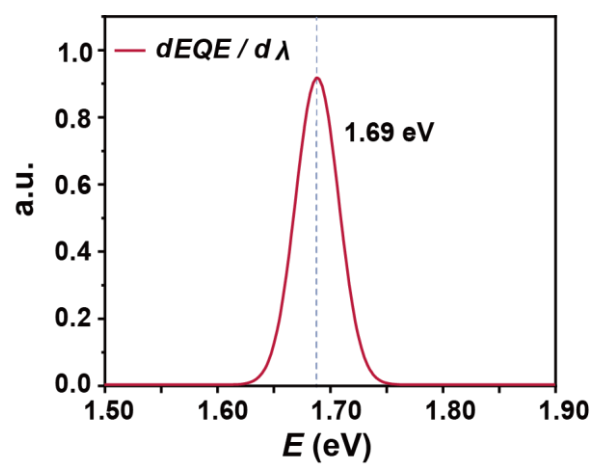
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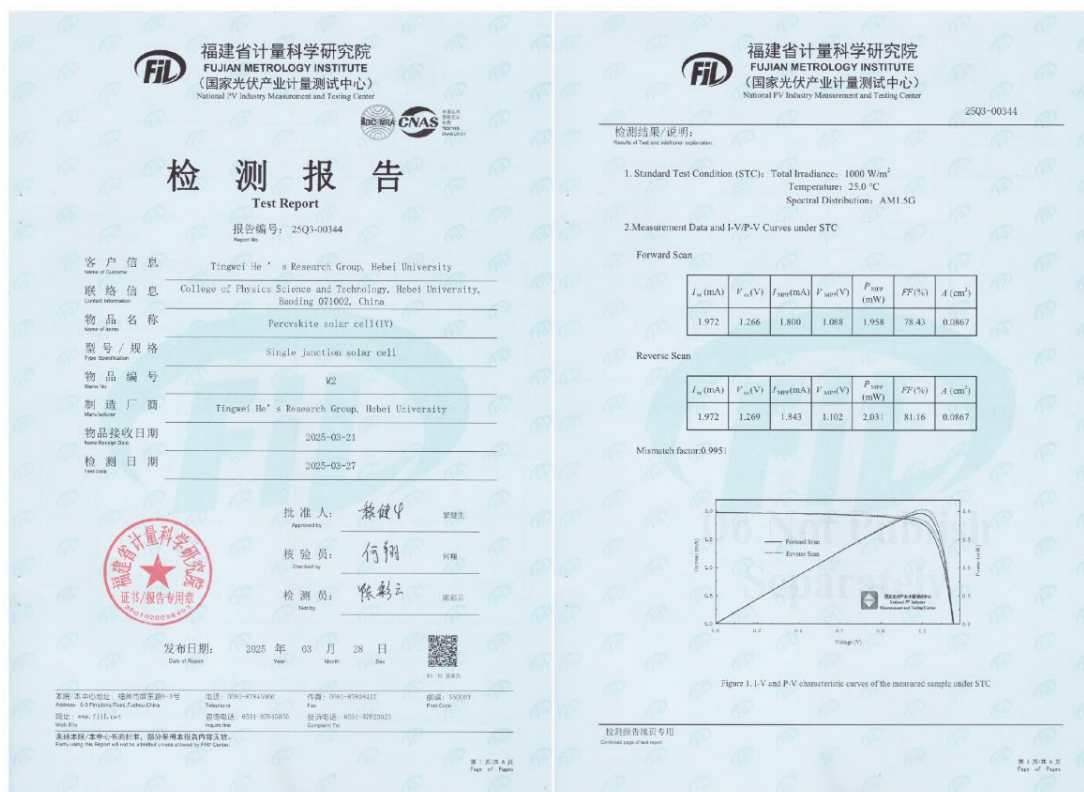
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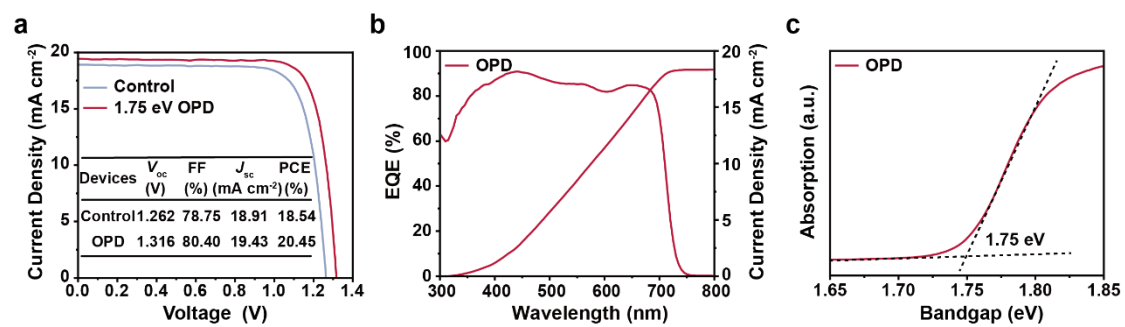
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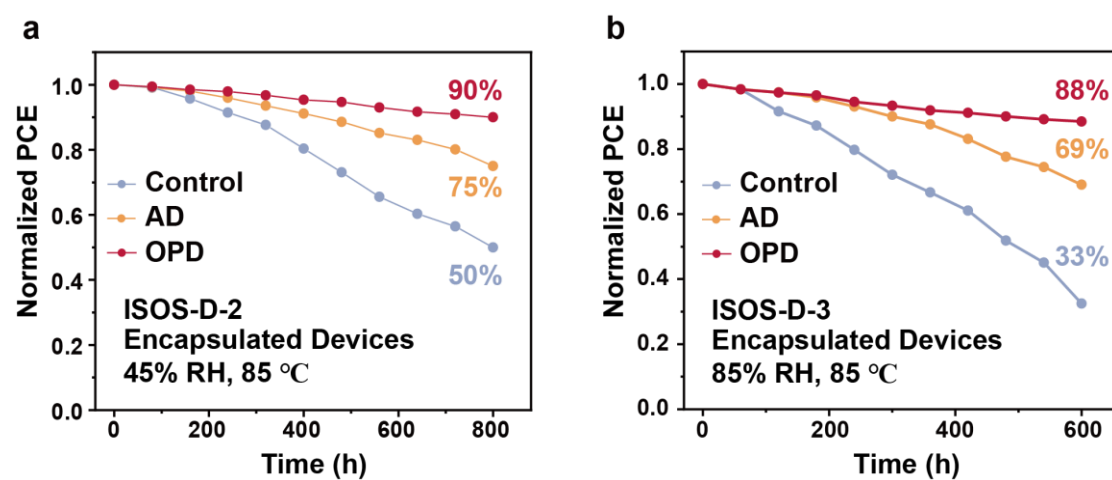
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Supplementary Fig. 43 | Damp-heat stability of PSCs under of (a) ISOS-D-2 and (b) ISOS-D-3 standard protocols.

Supplementary Tables

Supplementary Table S1 | Extracted q -value evolution of (100), (110), and (111) facets of control perovskite film at the spin-coating stage.

Time (s)	(100) facet (nm^{-1})	(110) facet (nm^{-1})	(111) facet (nm^{-1})
8	10.148	14.272	17.438
10	10.154	14.272	17.432
12	10.148	14.242	17.426
14	10.130	14.230	17.426
16	10.130	14.224	17.420
18	10.094	14.224	17.403
20	10.058	14.224	17.408
22	10.052	14.230	17.408
24	10.046	14.236	17.402
26	10.035	14.242	17.385
28	10.035	14.224	17.385
30	10.035	14.224	17.391
32	10.035	14.248	17.385
34	10.035	14.230	17.385
36	10.035	14.230	17.391
38	10.035	14.254	17.385
40	10.035	14.248	17.385

Supplementary Table 2. Material parameters used for simulation in SCAPS-1D.

Parameter	ITO	NiO _x	PVK	C ₆₀	BCP
Thickness: nm	100	30	500	30	8
Bandgap: eV	3.5	3.4	1.69	2.2	3.5
χ : eV	4.0	3.9	3.9	3.2	3.7
ε	9.0	9.0	18	7	10
N_C : cm ⁻³	2.2×10^{18}	1×10^{21}	2.1×10^{18}	2.2×10^{18}	2.2×10^{18}
N_V : cm ⁻³	1.8×10^{19}	2×10^{20}	2.1×10^{18}	1.8×10^{19}	1.8×10^{19}
μ_e : cm ⁻² V ⁻¹ s ⁻¹	20	20	1.77×10^{-3}	200	200
μ_h : cm ⁻² V ⁻¹ s ⁻¹	10	10	1×10^{-4}	80	80
N_D : cm ⁻³	2×10^{19}	1×10^{19}	-	-	-
N_A : cm ⁻³	-	-	1.0×10^{15}	1.0×10^{18}	1.0×10^{18}
N_t : cm ⁻³	1×10^{15}	1×10^{15}	2.31×10^{15}	1×10^{14}	1×10^{14}
V_e : cm s ⁻¹	1.0×10^7	1.0×10^7	1.0×10^7	1.0×10^7	1.0×10^7
V_h : cm s ⁻¹	1.0×10^7	1.0×10^7	1.0×10^7	1.0×10^7	1.0×10^7

χ : Electron affinities;

ε : Relative dielectric constant;

N_C : Effective state density of conduction band;

N_V : Effective state density of valence band;

μ_e : Electronic mobility;

μ_h : Hole mobility;

N_D : Donor concentration;

N_A : Acceptor concentration;

N_t : Recombination center concentration;

V_e : Thermal velocity of electron;

V_h : Thermal velocity of hole;

Supplementary Table 3. Summary on the photovoltaic parameters of WBG (1.65-1.71eV) PSCs extracted from recent literature.

Ref	E_g (eV)	V_{OC} (V)	J_{SC} (mA cm ⁻²)	FF (%)	PCE (%)
1	1.65	1.24	21.4	84.7	22.5
2	1.65	1.26	21.6	82.3	22.5
3	1.65	1.27	-	-	22.7
4	1.65	1.28	21.8	83.8	23.3
5	1.66	1.36	20.44	75.51	21.07
6	1.66	1.23	22.41	82	22.6
7	1.66	1.3	22.38	84.12	24.53
8	1.66	-	-	-	22.53
9	1.66	1.27	22.53	84.33	24.12
10	1.66	1.296	22.02	84.79	24.2
11	1.67	1.29	22.32	85	24.48
12	1.67	1.29	20.4	82.3	21.4
13	1.67	1.28	19.5	84	20.6
14	1.67	1.243	21.58	82.81	22.22
15	1.67	1.255	20.88	85.5	22.4
16	1.67	1.23	21.36	83.66	22
17	1.67	1.26	21.58	85.3	23.2
18	1.67	1.23	22.37	83.76	23.07
19	1.67	1.273	21.27	83.21	22.53
20	1.67	1.246	21.69	84.92	23.05
21	1.67	1.28	-	-	23.25
22	1.67	1.249	21.62	83.98	22.68
23	1.68	1.286	21.42	85.29	23.5
24	1.68	1.24	21.8	84.3	22.8
25	1.68	1.267	21.52	85.1	23.2

26	1.68	1.23	20.8	84.12	21.58
27	1.68	1.286	21.13	83.89	22.8
28	1.68	1.23	21.6	82.85	21.96
29	1.68	1.236	21.12	86.67	22.63
30	1.68	1.23	21.29	84.81	22.12
31	1.68	-	-	-	23.66
32	1.68	1.247	21.11	84.36	22.21
33	1.68	1.251	21.62	83.45	22.57
34	1.68	1.25	22.31	83	23.05
35	1.68	1.268	21.7	82.67	22.76
36	1.68	1.238	21.27	86.7	22.83
37	1.68	1.275	21.68	84.83	23.45
38	1.68	1.3	22.4	80.2	23.4
39	1.68	1.277	21.37	84.08	22.95
40	1.68	-	-	-	22.92
41	1.68	-	-	-	22.35
42	1.68	1.28	-	-	21.5
43	1.69	1.282	22.43	81.2	23.35
44	1.70	1.16	-	-	20.25
45	1.71	1.23	21.97	82.88	21.56
This Work	1.69	1.274	22.72	83.78	24.13

Supplementary Table 4. The photovoltaic parameters of a 4T TSCs.

Device	V_{oc} (V)	J_{sc} (mA cm ⁻²)	FF (%)	PCE (%)
ST-WBG PSCs	1.23	21.98	82.40	22.28
CIGS PSCs	0.76	28.62	80.45	17.49
Filtered CIGS PSCs	0.73	12.91	74.66	7.06
4T tandem cell				29.34

Supplementary Methods

Characterisation of perovskite films

X-ray photoelectron spectroscopy (XPS). Tests were transferred to an ultrahigh vacuum chamber (ESCALAB 250Xi), with a base pressure of 2×10^{-10} mbar, for XPS depth profiling measurements. The depth-profiling XPS measurements were performed using a double-differentially pumped He gas discharge lamp emitting He I radiation ($h\nu = 21.22$ eV).

The Fourier transform infrared spectroscopy (FTIR). Tests were measured on a PerkinElmer Spectrum Two infrared spectrometer.

Kelvin probe force microscopy (KPFM) and atomic force microscopy (AFM, MFP-3D, OXFORD, UK). Tests were performed using a Bruker Dimension Icon system. We used a platinum-iridium-coated PPP-EFM probe to perform measurements in tapping mode. In KPFM mode, an electrical resolution of approximately 10 mV was achieved by setting a phase-locked amplifier and signal filter. The conductive substrate of the perovskite sample was connected to the sample stage. The scanning rate was set to 0.4 Hz to ensure image quality. During the measurement, an AC bias voltage was applied to the probe, and the sample was grounded. Additionally, the AC bias generated an electric field force on the microcantilever that is proportional to the potential difference between the conductive atomic force microscopy probe and the sample.

Scanning electron microscopy (SEM) and energy dispersive X-ray spectroscopy (EDS). Images of perovskite films were characterized using a field emission Scanning Electron Microscope (SEM; JSM-7500F, JEOL).

Photoluminescence (PL) spectra. The steady-state PL spectra were measured by fluorescence spectrophotometer (Edinburgh instruments FLS 980) provided by a xenon lamp, and perovskite films were excited at 435 nm. The excitation source was a laser

diode (450 nm). The excitation source for Time-resolved photoluminescence (TRPL) spectra was a laser diode (450 nm). The photoluminescence lifetime can be defined by a double exponential decay equation:

$$f(t) = A_1 e^{\frac{-t}{\tau_1}} + A_2 e^{\frac{-t}{\tau_2}} \quad (1)$$

The space-charge-limited current (SCLC) measurement. Trap densities and mobilities of FTO/SnO₂/perovskite/PCBM/Ag electron-only device structures were measured using the SCLC model. The dark current-voltage (*I-V*) characteristics of the electron-only devices were measured by a Keithley 2400 source polarimeter. The onset voltage V_{TFL} is linearly related to the defect state density.

$$N_t = \frac{2\varepsilon_0 \varepsilon_r V_{TFL}}{qL^2} \quad (2)$$

$$\mu = \frac{8JL^3}{9\varepsilon_0 \varepsilon_r V_{TEL}^2} \quad (3)$$

Where I is the device current; ε_r is the relative dielectric constant; ε_0 is the vacuum permittivity; q is the elementary charge; L is the perovskite film thickness; J is current density.

Thermal admittance spectroscopy (TAS). The capacitance-frequency curve was measured with a PARSTAT 4000. The energy distribution of the trapped state density can be fitted by the following equation:

$$N_t(E_\omega) = -\frac{V_{bi}}{eW} \frac{dc}{d\omega} \frac{\omega}{k_B T} \quad (4)$$

Where V_{bi} is the built in voltage; ω is angular frequency; e is the elementary charge; W is the depletion width; C is the capacitance; k_B is the Boltzmann constant and T is the temperature.

In-situ UV-Vis absorption spectra, transmittance spectra and reflectance spectra.

It was acquired using a UV/vis spectrophotometer (Shimadzu UV-2550) equipped with an integrating sphere. The baseline spectrum (without sample) is acquired before measuring the transmittance of the devices in order to discard the fluctuations of the

lamp installed in our spectrophotometer. Each transmittance spectra is then normalized with respect to the baseline spectrum following this equation:

$$T(\lambda) = \frac{100T_{device}(\lambda)}{T_{baseline}(\lambda)} \quad (5)$$

$$R(\lambda) = \left(\frac{\vec{n}(\lambda) - n_0}{\vec{n}(\lambda) + n_0} \right)^2 \quad (6)$$

$$\vec{n}(\lambda) = n(\lambda) + ik(\lambda) \quad (7)$$

Where λ is the wavelength, n is the real part of the refractive index, k is the extinction coefficient, n_0 is the refractive index of the incident medium.

Characterization of photovoltaic devices

The Mott-Schottky measurement. Tests were determined the type of semiconductor and the carrier concentration and flat band potential. Space charge layer capacitance and potential E could be described by the Mott-Schottky equation. The equation that describes the differential capacitance of the space charge layer in a semiconductor.

Mott-Schottky formula:

$$\frac{1}{C^2} = \frac{2}{\epsilon\epsilon_0 e N_D} \left(V - V_{fb} - \frac{k_B T}{e} \right) \quad (8)$$

In the equation, V_{fb} is the flat band potential; N_D is carrier concentrations; ϵ is the relative dielectric constant; ϵ_0 is the vacuum permittivity; k_B is the Boltzmann Constant; T is the absolute temperature; e is the electric quantity per unit charge.

Electrochemical impedance spectra (EIS). Tests were measured using an electrochemical workstation. The light source was simulated by a xenon lamp-based solar simulator and the illumination intensity was adjusted by a filter. Impedance spectra were recorded in the frequency range of 0.2 to 2000 kHz by an Agilent E4980A precision LCR meter and homemade software. For complex resistance (R_{rec}) measurements, a bias voltage equal to V_{oc} was applied to the device under dark conditions.

Electroluminescence quantum efficiency (EQE_{EL}). The test was conducted using the Newport QE measurement kit, which consisted of a xenon lamp, monochromator, chopper and lock-in amplifier, and was equipped with a calibrated silicon photodetector. For the characteristic analysis of light-emitting diode devices, optical output measurements were carried out using a fiber optic integrating sphere (FOIS-1-FL) coupled with a QE 65 Pro spectrometer. The device was measured from zero bias voltage to forward bias voltage, with a scanning rate of 0.1 V s^{-1} and a residence time of 1 s. The characteristics of the device were analyzed using a fiber optic integrating sphere coupled with the QE 65 Pro spectrometer.

Theoretical Calculations

Calculation of the distance of facet. All calculations were carried out within the framework of density functional theory, using the project-enhanced facet wave method, which was implemented by the Vienna ab initio simulation package⁴⁶. The commutation-correlation potential function adopts the generalized gradient approximation proposed by Perdew, Burke and Ernzerhof. Long-range van der Waals interactions are described using the DFT-D3 method^{47,48}. The energy is truncated by A facet wave of 400 eV, with the energy convergence accuracy set at 1×10^{-5} eV atom⁻¹, and the force acting on each atom does not exceed 0.01 eV/Å⁻¹. The Brillouin District is integrated using a $3 \times 3 \times 1$ k-point grid.

Intermolecular interaction. All first-principle density functional theory (DFT) calculations for the Binding energy between cluster models were carried out using the Materials Studio (MS) with projector augmented-wave (PAW) potentials method. Geometry optimization using the generalized gradient approximation (GGA) of the Perdew-Burke-Ernzerhof (PBE) was used for the exchange-correlation functional, since it provides sufficient accuracy at an acceptable computational cost. The weak interaction forces are considered, and the accuracy of the calculation is guaranteed by combining the hybrid DFT model with the Grimme DFT-D3 dispersion correction of Becke-Johnson damping function, which was employed to improve the description of the long-range van der Waals interaction⁴⁸. The energy and force convergence parameters were set at 6^{-10} eV and 0.02 Ha Å⁻¹. $15 \text{ Å} \times 15 \text{ Å} \times 15 \text{ Å}$ cell with $1 \times 1 \times 1$ Γ -centered k-point grid was utilized. The adsorption energy between cluster models is defined as follows:

$$\Delta E = E_{AB} - (E_A + E_B) \quad (9)$$

In this equation, E_A , E_B , and E_{AB} are the energies of neutral A, B, and the whole system, respectively.

Binding energy between molecules and facet. All calculations were carried out within

the framework of density functional theory, using the project-enhanced facet wave method, which was implemented by the Vienna ab initio simulation package. The commutation-correlation potential function adopts the generalized gradient approximation proposed by Perdew, Burke and Ernzerhof. Long-range van der Waals interactions are described using the DFT-D3 method^{46,47}. The facet wave truncation energy is set at 400 eV, the energy convergence accuracy is set at 1×10^{-5} eV atom⁻¹, and the force acting on each atom does not exceed 0.01 eV Å⁻¹. In the Brillouin district, a $1 \times 1 \times 1$ k-point grid is used to integrate (100) and (110) PVK, and a $2 \times 2 \times 1$ k-point grid is used to integrate (111) PVK. The interaction can be calculated by the following equation:

$$E_{int} = E_{(perovskite \& \text{ additive molecule})} - E_{perovskite} - E_{additive \text{ molecule}} \quad (10)$$

SCAPS (Solar Cell Capacitance Simulator). The test was a numerical simulation of perovskite solar devices based on the fundamental equations of semiconductor physics and a self-consistent solution framework. The core of SCAPS was solved iteratively by coupling the Poisson equation, the electron-hole continuity equation, and the carrier transport equation with preset one-dimensional device geometries and hierarchical material parameters. The calculations strictly incorporate the characteristic physical models of perovskite materials, including but not limited to: defect state distribution (e.g., single energy level/Gaussian distribution defects in the bandgap), Shockley-Read-Hall composites, radiative composites, Auger composites, interfacial composites, ion mobility effects (via modified migration-diffusion equations or equivalent circuit models), energy band shifts, and tunnelling mechanisms. Boundary conditions were set based on the device electrode contact characteristics, and the carrier generation rate distribution under light conditions is considered. The solver used numerical methods (e.g., Newton's iterative method) to discretize the system of equations on a spatial grid until a convergence criterion was reached, and finally outputs key performance parameters such as steady-state or transient current-voltage characteristics (J - V curves), quantum efficiency (QE), capacitance-voltage characteristics (C - V), energy band

diagrams, and carrier concentration and complexity distributions of the devices. Solve the Poisson and continuity equations for electrons and holes according to the following equations⁴⁹:

$$\frac{d}{dx} \left[-\varepsilon(x) \frac{d\varphi}{dx} \right] = q[p_h(x) - n_e(x) + N_A^-(x) + p_t(x) - n_t(x)] \quad (11)$$

$$-\frac{1}{q} \frac{\partial J_n}{\partial x} - G(x) + R_n(x) = 0 \quad (12)$$

$$-\frac{1}{q} \frac{\partial J_p}{\partial x} - G(x) + R_p(x) = 0 \quad (13)$$

Where, ε is the relative permittivity; q is the electrical charge; N_A and N_D are the acceptor and donor concentrations, respectively; φ is the electrostatic potential; $G(\chi)$ is the optical generation rate; χ indicates the coordinate position; $P_t(\chi)$ and $P_l(\chi)$ are the trapped holes and electrons, respectively; and n_e and P_h indicate electron and hole densities, respectively. J_n and J_p denote the current densities of electrons and holes, respectively, and $R_n(\chi)$ and $R_p(\chi)$ denote the recombination rates of electrons and holes, respectively.

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